

## 47 CFR PART 15B

# **TEST REPORT**

of

#### USB modem

Trade Name:

Haier

Brand Name:

Haier

Model Name:

HC-CM210

Report No .:

SZ10070079E02

FCC ID.:

SG71007HC-CM210

prepared for

Qingdao Haier Telecom Co.,Ltd

No.1, Haier Road Hi-tech Zone, Qingdao, 266101, P.R.China

prepared by

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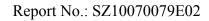








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# **TABLE OF CONTENTS**

1.	TEST RESULT CERTIFICATION			
2.	GENERAL INFORMATION			
2.1	Equipment	t under Test (EUT) l	Description4	
2.2	Test Standa	ards and Results	5	
2.3	Facilities a	nd Accreditations	6	
2.3.1	Facilities		6	
2.3.2	Test Envi	ronment Conditions.	6	
2.3.3	Measurer	nent Uncertainty	6	
3.	47 CFR PA	ART 15B REQUIRE	MENTS7	
3.1	General In	formation	7	
3.1.1	Test Mod	le	7	
3.1.2	Test Setu	p	8	
3.2	Conducted	Emission	10	
3.2.1	Requirem	nent	10	
3.2.2	Test Proc	edure	10	
3.2.3	Test Resu	ılt	11	
3.3	Radiated E	Emission	13	
3.3.1	Requirem	nent	13	
3.3.2	Test Procedure1			
3.3.3	Test Resu	ılt	14	
			Change History	
	Issue	Date	Reason for change	
	1.0	August 23, 2010	First edition	



## 1. Test Result Certification

Equipment under Test: USB modem

Trade Name: Haier Brand Name: Haier

Model Name: HC-CM210

FCC ID: SG71007HC-CM210

Applicant: Qingdao Haier Telecom Co., Ltd

No.1, Haier Road Hi-tech Zone, Qingdao, 266101, P.R.China

Manufacturer: Qingdao Haier Telecom Co.Ltd

No.1, Haier Road Hi-tech Zone, Qingdao, 266101, P.R.China

Emission Designator: 1M25F9W

Test Standards: 47 CFR Part 2

47 CFR Part 15 Subpart B

Test date: July 24, 2010-August 17, 2010

Test Result: PASS

## \* We Hereby Certify That:

The equipment under test was tested by Shenzhen Morlab Communications Technology Co., Ltd. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by: ......

Mo Huina

2010.08.23

Reviewed by:

Ni Young

Ni Yong

2010.06.23

Approved by:

and the same

2010.8.23



# 2. General Information

# 2.1 Equipment under Test (EUT) Description

Description ....: USB modem Model Name ....: HC-CM210

Serial No.....: (n.a, marked #1 by test site)

MEID.....: (n.a) Hardware Version....: 1.0

 Software Version
 CM210V1.0

 Modulation
 CM200V\_2.57

Frequency ....... Tx: 824.7 – 848.31 MHz; Rx: 869.7-893.31MHz

#### NOTE:

1. The EUT is a model of CDMA1X USB Modem.

2. The EUT can receive the electric power from the PC via USB point and can be used as a storage when inserted with a T-Flash card.

3. For detailed features about the EUT, please see user manual supplied by the applicant.



# 2.2 Test Standards and Results

The objective of the report is to perform tests according to 47 CFR Part 2, Part 15 Part 22 for FCC ID Certification:

No.	Identity	Document Title	
1	47 CFR Part 2	Frequency Allocations and Radio Treaty Matters; General Rules and	
	(10-1-09 Edition)	Regulations	
2	47 CFR Part 15	Radio Frequency Devices	
	(10-1-09 Edition)		

Test detailed items and the results are as below:

No.	Rules	Test Type	Result
FCC	Part 15 Requiremen	t	
1	§15.107	Conducted Emissions	PASS
2	§15.109	Radiated Emissions	PASS

### NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.



## 2.3 Facilities and Accreditations

#### 2.3.1 Facilities

Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is CNAS L3572.

All measurement facilities used to collect the measurement data are located at 3/F, Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055 P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

#### 2.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 -60
Atmospheric Pressure (kPa):	86-106

## 2.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB



# 3. 47 CFR Part 15B Requirements

### 3.1 General Information

#### **3.1.1 Test Mode**

The test modes of the EUT are showed as below:

#### (1) Call Mode:

The EUT configuration of the emission tests was MS + PC + earphone.

Before the measurement, the lithium battery was completely discharge.

During the measurement, the lithium battery was installed into the MS, and the charger was connected to the MS. A communication link was established between the MS and a System Simulator (SS).

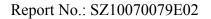
## (2) USB Test Mode

The EUT configuration of the emission tests is <u>TransFlash Card + EUT+ PC.</u>

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a special USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), simultaneity, the date is transmitting between the PC and the TransFlash Card of the EUT.

#### NOTE:

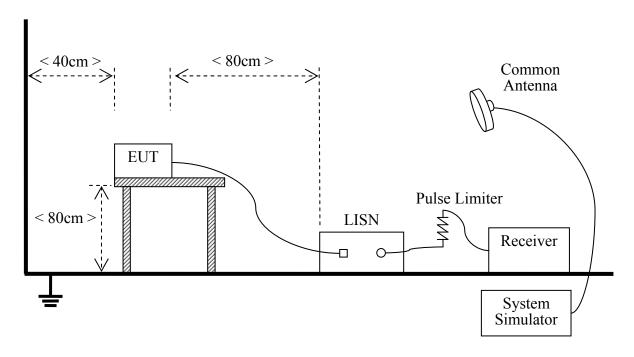
1. All test modes are performed, only the worst cases are recorded in this report.





# 3.1.2 Test Setup

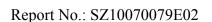
#### 3.1.2.1 Conducted Emission Test



- 1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
- 3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument.

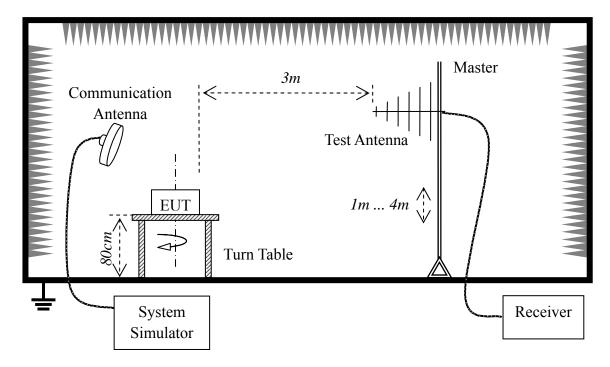
## 4. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Agilent	E7405A	US44210471	2009.09	1year
LISN	Schwarzbeck	NSLK 8127	812744	2009.09	1year
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	(n.a.)	(n.a.)
System Simulator	Agilent	E5515C	GB43130131	2009.09	1year
Personal Computer	IBM	IBM_T20	(n.a)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)





### 3.1.2.2 Radiated Emission Test



- 1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the trilogy Test Antenna, which is mounted on the top of a variable-height antenna Master tower.

3. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal.	Cal. Due
				Date	
Receiver	Agilent	E7405A	US44210471	2009.09	1 year
Semi-Anechoic	Albatross	9m*6m*6m	(n.a.)	2009.09	2year
Chamber					
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2009.09	1 year
Test Antenna - Horn	Schwarzbeck	BBHA 9120C	9120C-384	2009.09	1 year
System Simulator	Agilent	E5515C	GB43130131	2009.09	1 year
Personal Computer	IBM	IBM_T20	(n.a)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)

### NOTE:

4. The test method is the substitution method according to TIA-603-C.



## 3.2 Conducted Emission

## 3.2.1 Requirement

According to FCC §15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu\text{H}/50\Omega$  line impedance stabilization network (LISN).

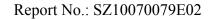
Fraguanay ranga (MUz)	Conducted Limit (dBμV)		
Frequency range (MHz)	Quasi-peak	Average	
0.15 - 0.50	66 to 56	56 to 46	
0.50 - 5	56	46	
5 - 30	60	50	

#### NOTE:

- 1. The limit subjects to the Class B digital device.
- 2. The lower limit shall apply at the band edges.
- 3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

#### 3.2.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.1.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
- 3. The emission levels at both L phase and N phase should be tested.
- 4. Record the test result plot and distinct points.
- 5. In the test report show the worst test data.

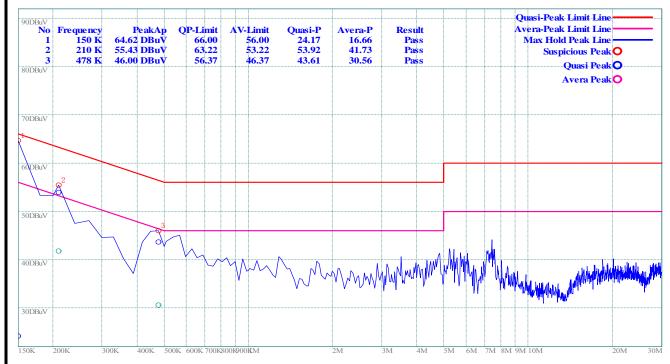




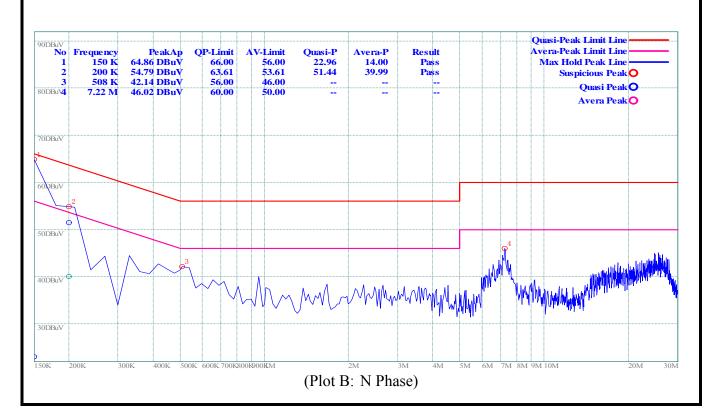
#### 3.2.3 Test Result

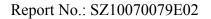
### (1) Call Mode

## A. Test Plot and Suspicious Points:



(Plot A: L Phase)

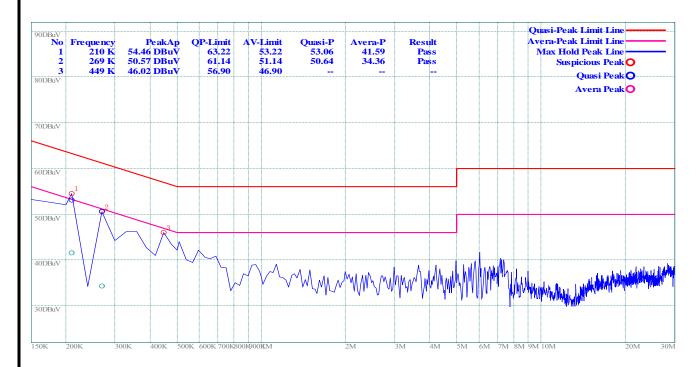




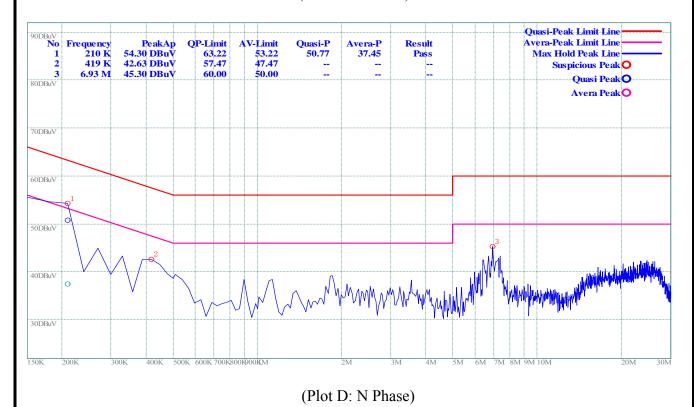


#### (2) USB Mode

## A. Test Plot and Suspicious Points:



(Plot C: L Phase)





## 3.3 Radiated Emission

## 3.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

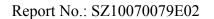
Fraguenay ranga (MHz)	Field Strength		
Frequency range (MHz)	$\mu V/m$	dBμV/m	
30 - 88	100	40	
88 - 216	150	43.5	
216 - 960	200	46	
Above 960	500	54	

#### NOTE:

- 1. Field Strength  $(dB\mu V/m) = 20*log[Field Strength (\mu V/m)].$
- 2. In the emission tables above, the tighter limit applies at the band edges.

#### 3.3.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.2.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
- 3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
- 4. The emission levels at both horizontal and vertical polarizations should be tested.
- 5. Record the test result plot and distinct points.
- 6. In the test report show the worst test data.



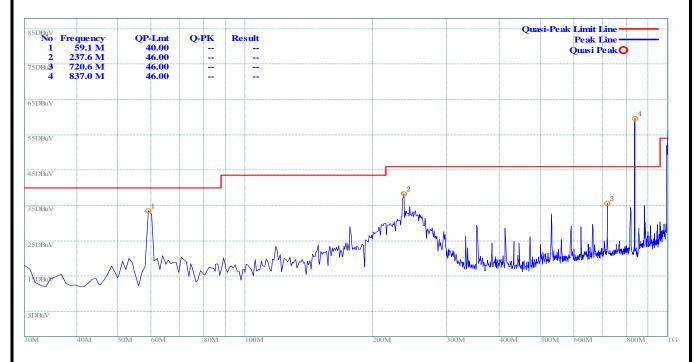


#### 3.3.3 Test Result

### (1) Call Mode

## A. Test Plot and Suspicious Points:

Note: Following is the plots for emission measurement; please note that marked spikes near 850MHz with circle should be ignored because they are MS and SS carrier frequency.



(Plot A: Test Antenna Vertical)

